

PATENT NUMBER

U.S. UTILITY Patent Application
O.I.P.E. PATER SCANNED HKM 1

PATENT DATE

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APPLICATION NO.	CONT/PRIOR CLASS	SUBCLASS	ART UNIT	EXAMINER
09/972622:	D 324	754	3 729 2829	NGUYEN, VINH

Brian Beaman Keith Fogel Paul Lauro Maurice Norcott

High density integral test probe and fabrication matter.

Devices

Devices

(Attached in pocket on right inside flap)

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ISSUING CLASSIFICATION									
ORIGINAL			CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
NTERNATIONAL	CLASSIFICATION								
		†							
			Continued on Issue Slip Inside File Jacket						

TERMINAL	-	DRAWINGS		CLAIMS ALLOWED		
DISCLAIMER	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.	
☐ The term of this patent	·			NOTICE OF ALLOWANCE MAILED		
subsequent to (date)	-					
has been disclaimed.	(Assistant	Examiner)	(Date)			
☐ The term of this patent shall						
not extend beyond the expiration date of U.S Patent. No.	·			ISSUE FEE		
				Amount Due	Date Paid	
	(Primary I	Examiner)	(Date)			
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this patent have been disclaimed.	(Legal Instruments Examiner)		(Date)			
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(FACE)